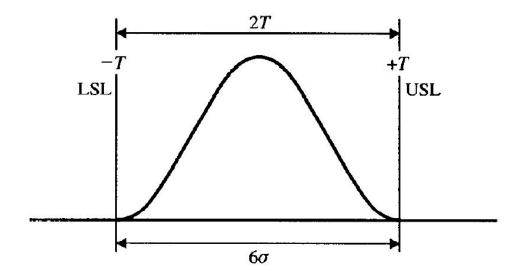
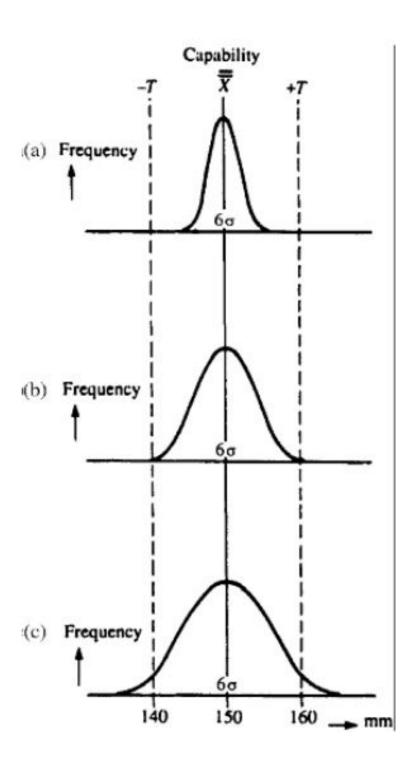
0.1 Process Capability

- In managing variables the usual aim is not to achieve exactly the same diameter for every piston, the same weight for every tablet, sales figures exactly as forecast, etc but to reduce the variation of products and process parameters around a **target value**.
- No adjustment of a process is called for as long as there has been no identified change in its accuracy or precision. This means that, in controlling a process, it is necessary to establish first that it is in statistical control, and then to compare its centering and spread with the specified target value and specification tolerance.
- We have seen previously that, if a process is not in statistical control, special causes of variation may be identified with the aid of *control charts*.
- Only when all the special causes have been accounted for, or eliminated, can process capability be sensibly assessed. The variation due to common causes may then be examined and the "natural specification" compared with any imposed specification or tolerance zone.
- The relationship between process variability and tolerances may be formalized by consideration of the standard deviation, σ , of the process.
- In order to manufacture within the specification, the distance between the **upper specification limit** (USL) or upper tolerance (+T) and **lower specification limit** (LSL) or lower tolerance (-T), i.e. (USL LSL) or 2T must be equal to or greater than the width of the base of the process bell, i.e. 6σ .



The relationship between USL-LSL (i.e. 2T) and 6σ gives rise to three levels of precision of the process (Figure below):

- (a) **High Relative Precision**, where the tolerance band is very much greater than 6σ $(2T >> 6\sigma)$
- (b) Medium Relative Precision, where the tolerance band is just greater than 6σ ($2T > 6\sigma$)
- (c) Low Relative Precision, where the tolerance band is less than 6σ (2T < 6σ)



0.1.1 Process Capability Indices

- A process capability index is a measure relating the actual performance of a process to its specified performance, where processes are considered to be a combination of the plant or equipment, the method itself, the people, the materials and the environment.
- These indices assumes process output is approximately normally distributed.
- The absolute minimum requirement is that three process standard deviations each side of the process mean are contained within the specification limits.
- This means that approximately 99.7 per cent of output will be within the tolerances. A more stringent requirement is often stipulated to ensure that produce of the correct quality is consistently obtained over the long term.
- When a process is under statistical control (i.e. only random or common causes of variation are present), a process capability index may be calculated.
- Process capability indices are simply a means of indicating the variability of a process relative to the product specification tolerance.

\mathbf{C}_p index

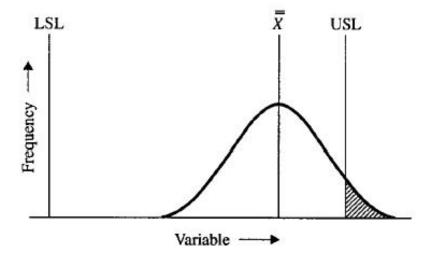
- In order to manufacture within a specification, the difference between the USL and the LSL must be less than the total process variation.
- A comparison of 6σ with (USL-LSL) or 2T gives an obvious process capability index, known as the C_p of the process:

$$\hat{C}_p = \frac{USL - LSL}{6\hat{\sigma}}$$

- This estimates what the process is capable of producing if the process mean were to be centered between the specification limits. Clearly, any value of C_p below 1 means that the process variation is greater than the specified tolerance band so the process is incapable.
- For increasing values of C_p the process becomes increasingly capable. The C_p index makes no comment about the centring of the process, it is a simple comparison of total variation with tolerances.

C_{pk} index

• It is possible to envisage a relatively wide tolerance band with a relatively small process variation, but in which a significant proportion of the process output lies outside the tolerance band (Figure below).

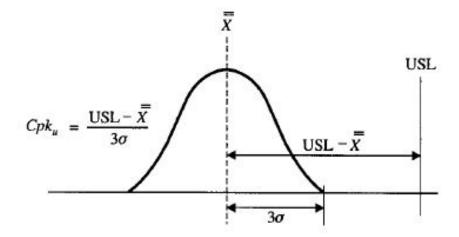


• This does not invalidate the use of Cp as an index to measure the potential capability of a process when centred, but suggests the need for another index which takes account of both the process variation and the centring. Such an index is the C_{pk} , which is widely accepted as a means of communicating process capability.

$$Cpk_{\rm u} = \frac{{\rm USL} - \overline{X}}{3\sigma}$$
 $Cpk_{\rm l} = \frac{\overline{X} - {\rm LSL}}{3\sigma}.$

- For upper and lower specification limits, there are two C_{pk} values, C_{pku} and C_{pkl} . These relate the difference between the process mean and the upper and the lower specification limits respectively, to 3σ (half the total process variation).
- The overall process C_{pk} is the lower value of C_{pku} and C_{pkl} . A C_{pk} of 1 or less means that the process variation and its centring is such that at least one of the tolerance limits will be exceeded and the process is incapable. As in the case of C_p , increasing values of C_{pk} correspond to increasing capability.

• It may be possible to increase the C_{pk} value by centring the process so that its mean value and the mid-specification or target, coincide. A comparison of the C_p and the C_{pk} will show zero difference if the process is centred on the target value.



• The C_{pk} can be used when there is only one specification limit, upper or lower a one-sided specification. This occurs quite frequently and the C_p index cannot be used in this situation.

Example 1

Example 1.

In tablet manufacture, the process parameters from 20 samples of size n=4 are:

Mean Range (\overline{R}) = 91 mg, Process mean (\overline{X}) = 2500 mg Specified requirements USL = 2650 mg, LSL = 2350 mg Standard Deviation (s) = 44.2

$$Cp = \frac{\text{USL} - \text{LSL}}{6\sigma}$$
 or $\frac{2T}{6\sigma} = \frac{2650 - 2350}{6 \times 44.2} = \frac{300}{265.2} = 1.13$

$$Cpk = \text{lesser of } \frac{\text{USL} - \overline{X}}{3\sigma} \quad \text{or } \frac{\overline{X} - \text{LSL}}{3\sigma}$$

$$= \frac{2650 - 2500}{3 \times 44.2} \quad \text{or } \frac{2500 - 2350}{3 \times 44.2} = 1.13.$$

Example 2

Example 2.

If the process parameters from 20 samples of size n=4 are:

Mean range $(\overline{R}) = 91 \,\text{mg}$, Process mean $(\overline{\overline{X}}) = 2650 \,\text{mg}$

Specified requirements USL = 2750 mg, LSL = 2250 mg

Standard Deviation (s) = 44.2

$$Cp = \frac{\text{USL} - \text{LSL}}{6\sigma}$$
 or $\frac{2T}{6\sigma} = \frac{2750 - 2250}{6 \times 44.2} = \frac{500}{265.2} = 1.89$

$$Cpk$$
 = lesser of $\frac{2750 - 2650}{3 \times 44.2}$ or $\frac{2650 - 2250}{3 \times 44.2}$
= lesser of 0.75 or 3.02 = 0.75.

Conclusion – the Cp at 1.89 indicates a potential for higher capability than in example (i), but the low Cpk shows that this potential is not being realized because the process is not centred.

It is important to emphasize that in the calculation of all process capability indices, no matter how precise they may appear, the results are only ever approximations we never actually know anything, progress lies in obtaining successively closer approximations to the truth. In the case of the process capability this is true because:

- there is always some variation due to sampling;
- no process is ever fully in statistical control;
- no output exactly follows the normal distribution or indeed any other standard distribution.

Interpreting process capability indices without knowledge of the source of the data on which they are based can give rise to serious misinterpretation.

Interpreting capability indices - IMPORTANT

In the calculation of process capability indices so far, we have derived the standard deviation, σ , and recognized that this estimates the short-term variations within the process. This short term is the period over which the process remains relatively stable, but we know that processes do not remain stable for all time and so we need to allow within the specified tolerance limits for:

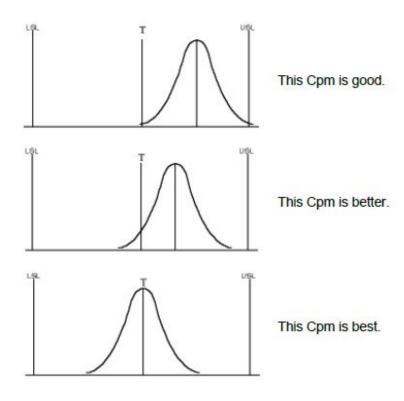
- some movement of the mean;
- the detection of changes of the mean;
- possible changes in the scatter (range);
- the detection of changes in the scatter;
- the possible complications of non-normal distributions.

Taking these into account, the following values of the C_{pk} index represent the given level of confidence in the process capability:

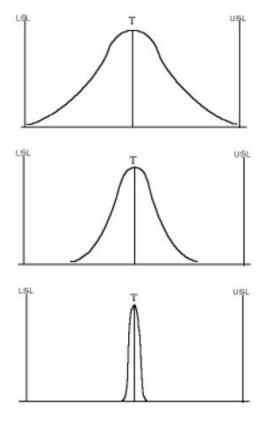
- $C_{pk} < 1$ A situation in which the production system is **not capable** and there will inevitably be non-conforming output from the process.
- $C_{pk} = 1$ A situation in which the production system is not really capable, since any change within the process will result in some undetected non-conforming output.
- $C_{pk} = 1.33$ A still far from acceptable situation since non-conformance is not likely to be detected by the process control charts.
- $C_{pk} = 1.5$ Not yet satisfactory since non-conforming output will occur and the chances of detecting it are still not good enough.
- $C_{pk} = 1.67$ Promising, non-conforming output will occur but there is a very good chance that it will be detected.
- $C_{pk} = 2$ High level of confidence in the production system, provided that control charts are in regular use.

The C_{pm} Index

- Another Index C_{pm} incorporates the target when calculating the standard deviation. The standard error, denoted $\hat{\sigma}_{Cpm}$ compares each observation to a reference value.
- However, instead of comparing the data to the mean, the data is compared to the target. These differences are squared. Thus any observation that is different from the target observation will increase the $\hat{\sigma}_{Cpm}$ standard deviation.
- As this difference increases, so does the Cpm. And as this index becomes larger, the C_{pm} gets smaller.
- If the difference between the data and the target is small, so too is the sigma. And as this sigma gets smaller, the Cpm index becomes larger. The higher the C_{pm} index, the better the process.
- In the following charts the process is the same, but as the process becomes more centred, the C_{pm} gets better.



In these 3 charts, the process stays centred about the target, but as the variation is reduced, the $\rm Cpm$ gets better.



This Cpm is reasonably good.

This Cpm is better.

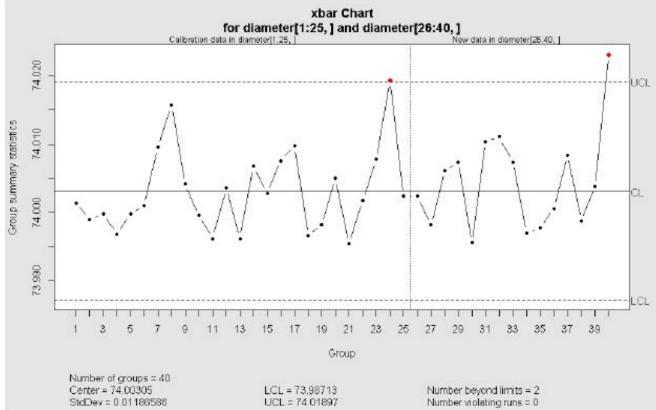
This Cpm is best.

	Population Known	Population Unknown
Ср	$C_p = rac{USL - LSL}{6\sigma}$	$\hat{C}_p = rac{USL - LSL}{6s}$
Cpk	$C_{pk} = \min\left[\frac{USL - \mu}{3\sigma}, \frac{\mu - LSL}{3\sigma}\right]$	$\hat{C}_{pk} = \min\left[\frac{USL - \bar{x}}{3s}, \frac{\bar{x} - LSL}{3s}\right]$
Cpm	$C_{pm} = rac{USL - LSL}{6\sqrt{\sigma^2 + (\mu - T)^2}}$	$\hat{C}_{pm} = rac{USL - LSL}{6\sqrt{s^2 + (ar{x} - T)^2}}$

0.1.2 Worked Example with R

Data set used diameter (piston rings data set)
R code used previously, reminding ourselves about the data set.

```
data(pistonrings)
attach(pistonrings)
dim(pistonrings)
diameter <- qcc.groups(diameter, sample)
obj <- qcc(diameter[1:25,], type="xbar",
newdata=diameter[26:40,])</pre>
```



0.1.3 Implementation of Process Capability Analysis

Indices and Confidence intervals for those indices.

```
> process.capability(obj, spec.limits=c(73.95,74.05))
Process Capability Analysis
Call:
process.capability(object = obj, spec.limits = c(73.95,
74.05))
Number of obs = 125
                            Target = 74
      Center = 74.00305
                               LSL = 73.95
      StdDev = 0.01186586
                               USL = 74.05
Capability indices:
     Value 2.5%
                   97.5%
     1.405 1.230 1.579
Ср
     1.490
           1.327 1.653
Cp 1
     1.319
            1.173 1.465
Cp u
     1.319 1.145 1.493
Cp k
     1.360
            1.187 1.534
Cpm
Exp<LSL 0%
            Obs<LSL 0%
Exp>USL 0%
            Obs>USL 0%
```

